Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/780,673	HAN, JONG-HEE	
Examiner	Art Unit	
Vivek Srivastava	2611	

SEARCHED						
Class	Subclass	Date	Examiner			
725	25-31	3/4/2005	vs			
380	205, 206	3/4/2005	vs			
380	210-213	3/4/2005	vs			
380	221	3/4/2005	vs			
348	528	3/4/2005	vs			
			,			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	-				
,					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
·				
·				